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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
In re PATENT APPLICATION OF

NAVARRO y KOREN et al.

Group Art Unit: UNKNOWN

Application No. TO BE ASSIGNED

Examiner: UNKNOWN

Filed: September 22, 2003

**Title: ALIGNMENT SYSTEM AND METHODS FOR LITHOGRAPHIC SYSTEMS
USING AT LEAST TWO WAVELENGTHS**

* * * * *

September 22, 2003

PRELIMINARY AMENDMENT

**Hon. Commissioner of Patents
P.O. Box 1450
Alexandria, VA 22313-1450**

Sir:

Prior to the initial examination of the above-identified application, please amend the application as follows.

This Preliminary Amendment is being presented in the REVISED FORMAT approved in February, 2003.